

**Search Notes**

Application/Control No.

10/765,726

Examiner

Charles Shedrick

Applicant(s)/Patent under  
Reexamination

CHINITZ ET AL.

Art Unit

2687

**SEARCHED**

Class	Subclass	Date	Examiner
455	418	10/18/2005	CS
370	311	10/18/2005	CS
395	200.11	10/18/05	CS

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted w/ Benny Tieu for Double Patent FP	10/18/2005	CS